

P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^e	Q _g (Typ.)
- 20	0.0106 at V _{GS} = - 4.5 V	- 25	57 nC
	0.0136 at V _{GS} = - 2.5 V	- 25	
	0.0189 at V _{GS} = - 1.8 V	- 25	

FEATURES

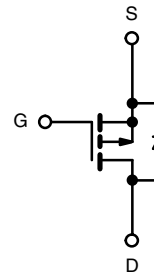
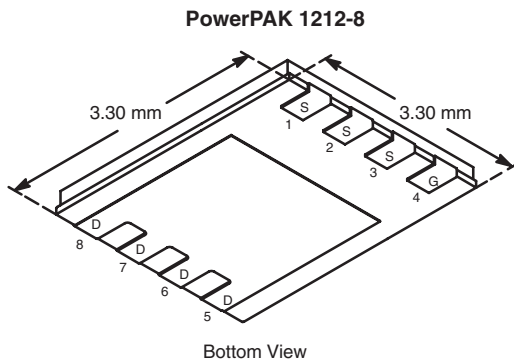
- Halogen-free
- TrenchFET[®] Power MOSFET
- Low Thermal Resistance PowerPAK[®] Package with Small Size and Low 1.07 mm Profile
- 100% UIS Tested



RoHS
COMPLIANT

APPLICATIONS

- Load Switch



Ordering Information: Si7123DN-T1-GE3 (Lead (Pb)-free and Halogen-free)

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 20	V	
Gate-Source Voltage	V _{GS}	± 8		
Continuous Drain Current (T _J = 150 °C)	I _D	T _C = 25 °C	- 25 ^e	A
		T _C = 70 °C	- 25 ^e	
		T _A = 25 °C	- 16 ^{a, b}	
		T _A = 70 °C	- 13 ^{a, b}	
Pulsed Drain Current	I _{DM}	- 40		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	- 25 ^e	
		T _A = 25 °C	- 3.0 ^{a, b}	
Avalanche Current	I _{AS}	- 25		
Single-Pulse Avalanche Energy	E _{AS}	31	mJ	
Maximum Power Dissipation	P _D	T _C = 25 °C	52	W
		T _C = 70 °C	33	
		T _A = 25 °C	3.7 ^{a, b}	
		T _A = 70 °C	2.4 ^{b, c}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{c, d}		260		

Notes:

- Surface Mounted on 1" x 1" FR4 board.
- t = 10 s.
- See Solder Profile (<http://www.vishay.com/ppg?73257>). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Package Limited.
- T_C = 25 °C.

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, b}	$t \leq 10$ s	R_{thJA}	26	33	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	1.9	2.4	

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
b. Maximum under Steady State conditions is 81 °C/W.

SPECIFICATIONS $T_J = 25$ °C, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0$ V, $I_D = -250$ μ A	-20			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250$ μ A		-19		mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			3		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = -250$ μ A	-0.4		-1	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0$ V, $V_{GS} = \pm 8$ V			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -20$ V, $V_{GS} = 0$ V			-1	μ A
		$V_{DS} = -20$ V, $V_{GS} = 0$ V, $T_J = 55$ °C			-10	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \geq -5$ V, $V_{GS} = -10$ V	-10			A
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	$V_{GS} = -4.5$ V, $I_D = -15$ A		0.0086	0.0106	Ω
		$V_{GS} = -2.5$ V, $I_D = -11.2$ A		0.0112	0.0136	
		$V_{GS} = -1.8$ V, $I_D = -5$ A		0.0156	0.0189	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -15$ V, $I_D = -4$ A		27		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{DS} = -10$ V, $V_{GS} = 0$ V, $f = 1$ MHz		3729		pF
Output Capacitance	C_{oss}			542		
Reverse Transfer Capacitance	C_{rss}			475		
Total Gate Charge	Q_g	$V_{DS} = -10$ V, $V_{GS} = -4.5$ V, $I_D = -15$ A		57	90	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -10$ V, $V_{GS} = -2.5$ V, $I_D = -15$ A		35.5	55	
Gate-Drain Charge	Q_{gd}			4.5		
Gate Resistance	R_g	$f = 1$ MHz		2.0		Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -10$ V, $R_L = 0.77$ Ω $I_D \cong -13$ A, $V_{GEN} = -4.5$ V, $R_g = 1$ Ω		25	50	ns
Rise Time	t_r			88	150	
Turn-Off Delay Time	$t_{d(off)}$			82	150	
Fall Time	t_f			28	45	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25$ °C			-25	A
Pulse Diode Forward Current ^a	I_{SM}				-40	
Body Diode Voltage	V_{SD}	$I_S = -13$ A		-0.76	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -13$ A, $di/dt = 100$ A/ μ s, $T_J = 25$ °C		48	80	ns
Body Diode Reverse Recovery Charge	Q_{rr}			45	80	nC
Reverse Recovery Fall Time	t_a			19		ns
Reverse Recovery Rise Time	t_b			29		

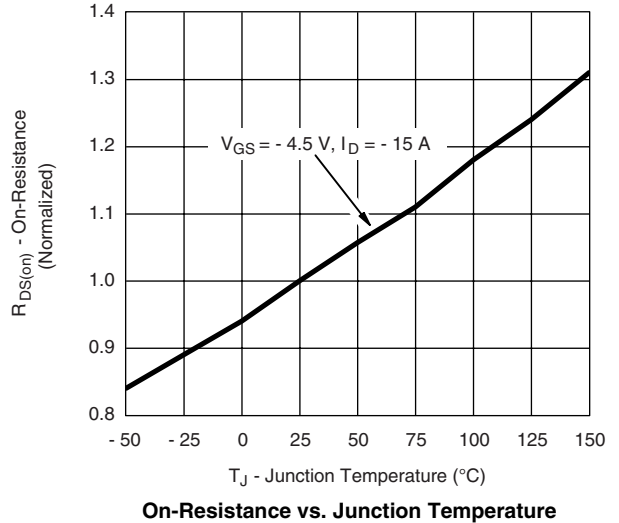
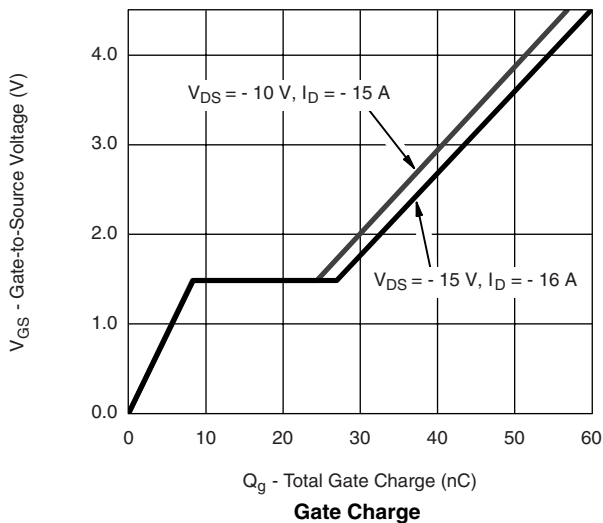
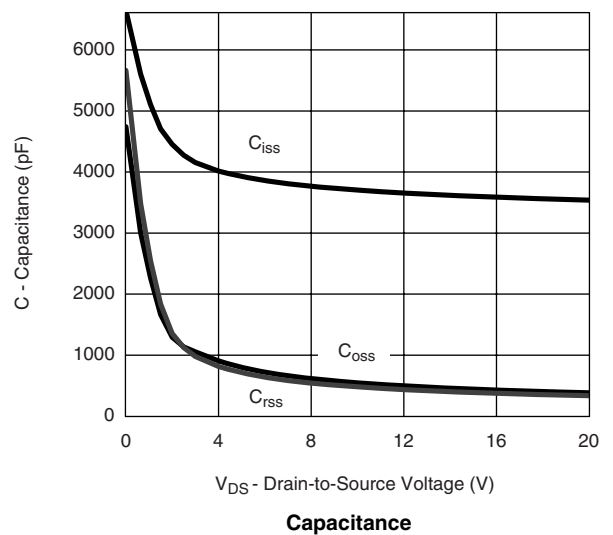
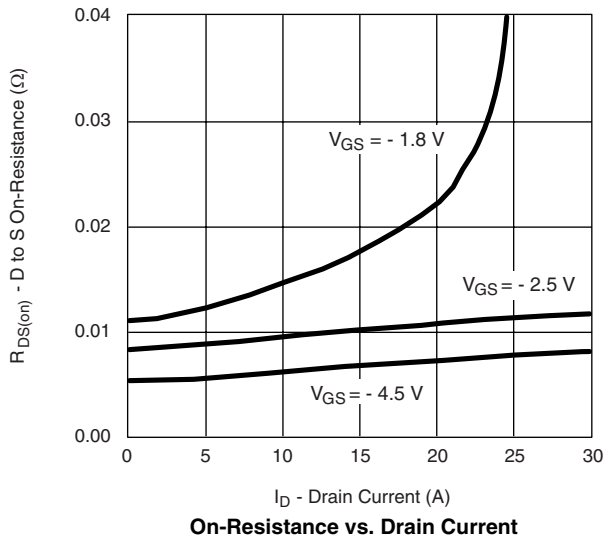
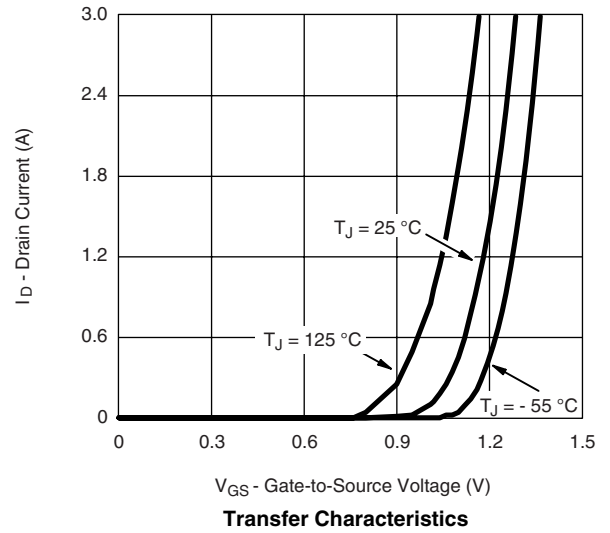
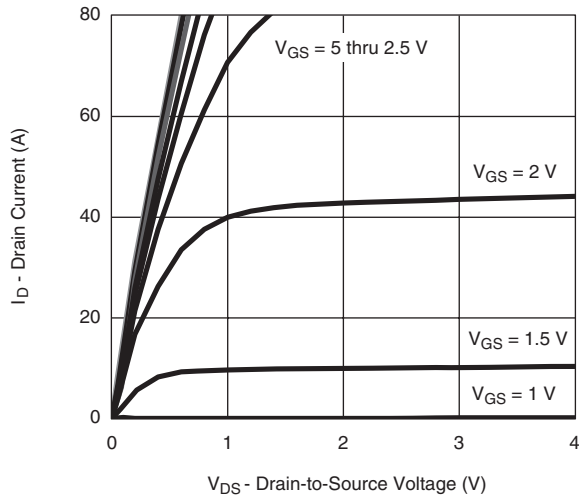
Notes:

- a. Pulse test; pulse width ≤ 300 μ s, duty cycle ≤ 2 %.
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

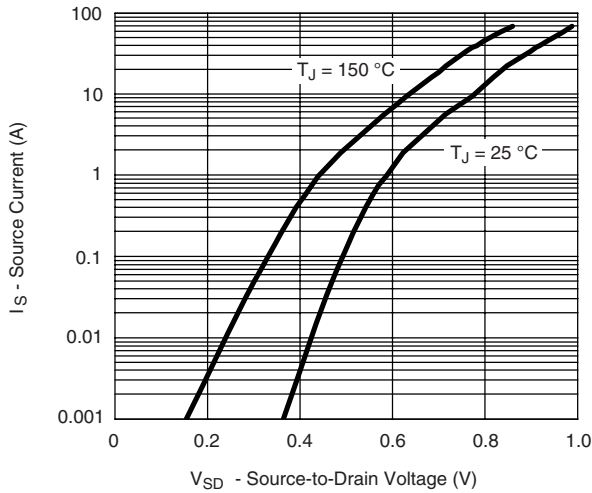


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

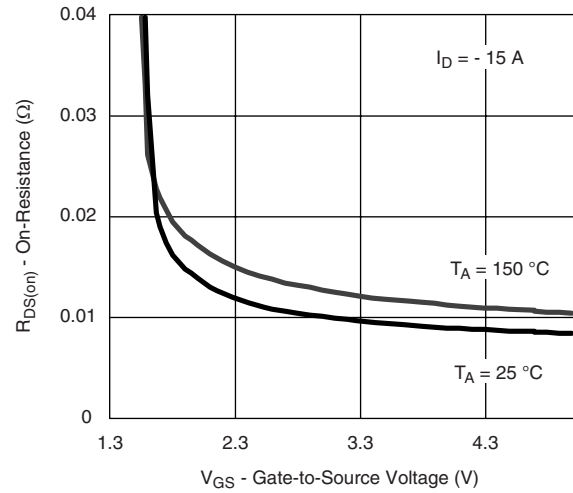




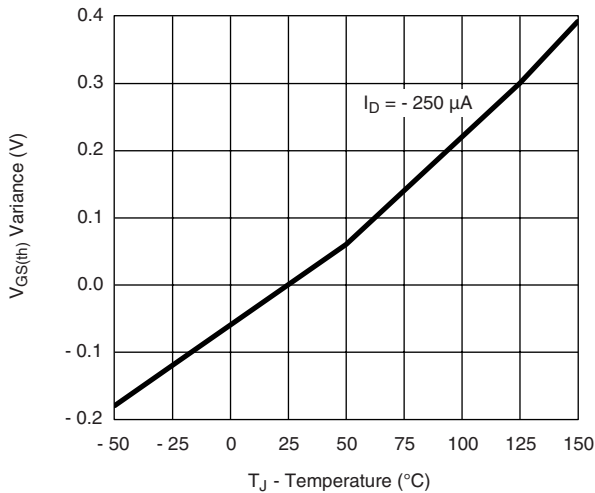
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



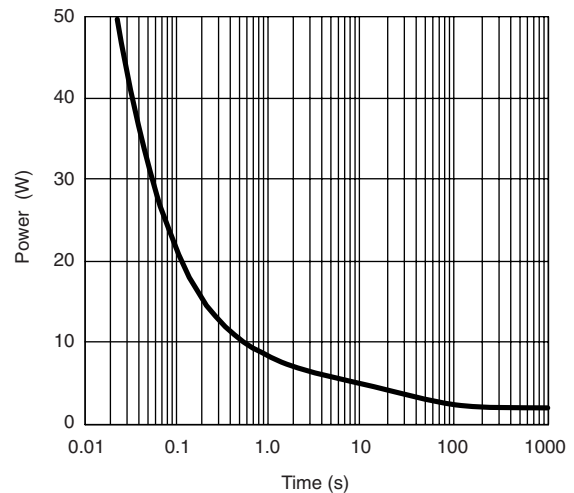
Source-Drain Diode Forward Voltage



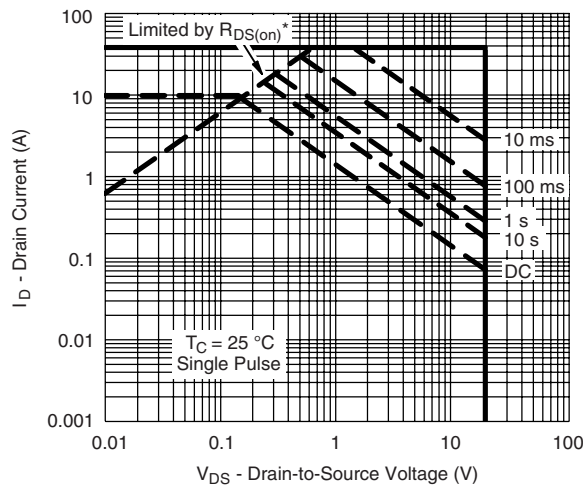
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



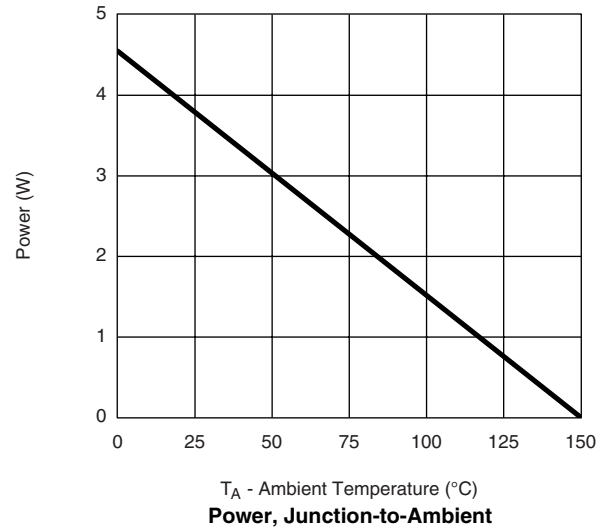
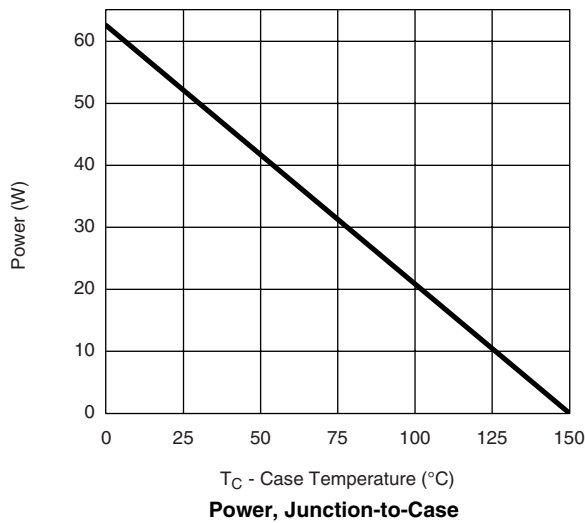
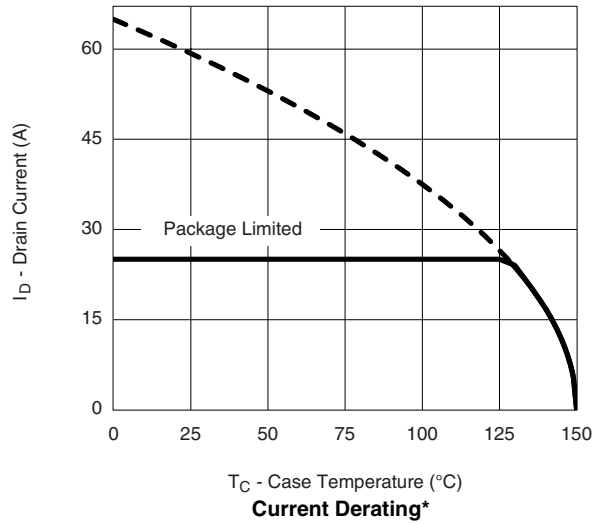
Single Pulse Power, Junction-to-Ambient



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

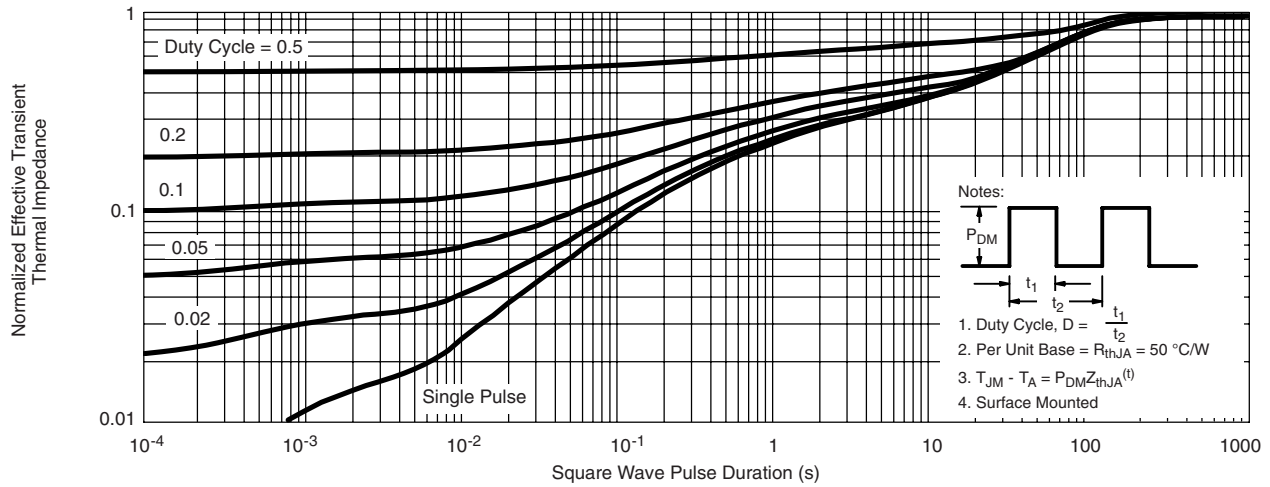
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

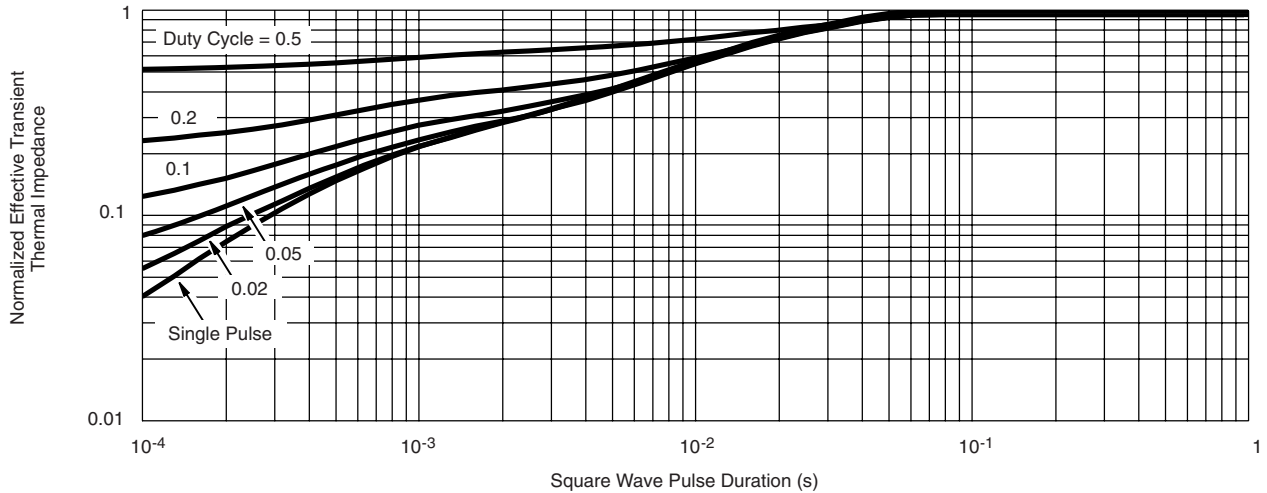


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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